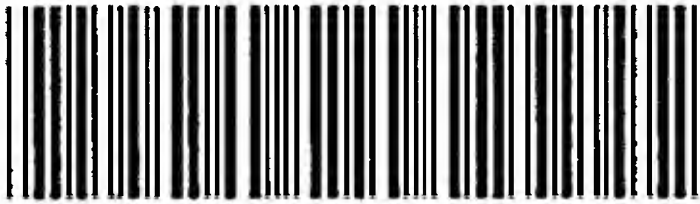


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/605,481	CHEN ET AL.	
	Examiner	Art Unit	
	Eugene Lee	2815	

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Class	Subclass	Date	Examiner
257	347,348	2/15/2005	EL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
searched EAST, USPAT, JPO, EPO	2/15/2005	EL